Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/024,309	LEE ET AL.	
Examiner	Art Unit	
John Pezzlo	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
370	401, 345,5	4)			
	278,28 400,491 238	2			
	238	73/21	106 8		
709.	238-24 203	2			
	203				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	400	7		
	238	/		
	282	3/20/0	6 X	
709	703 938			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
refer to up da EAST Stæreh	53/20/	66 96		